

250	396R
Class	Subclass
ISSUE CLASSIFICATION	

PATENT NUMBER

## U.S. UTILITY Patent Application

<p>O.I.P.E.</p> <p>SCANNED <i>Am</i><sup>2</sup> Q.A. <i>A.G.</i></p>	<p>PATENT DATE</p>
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APPLICATION NO. 09/708590	CONT/PRIOR F	CLASS 250	SUBCLASS 400	ART UNIT 2881	EXAMINER Arroyo
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## APPLICANTS

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Yoshikio Yui

**TITLE**

Correcting method for correcting exposure data used for a charged particle beam exposure system

PTO-2040  
12/89

**ISSUING CLASSIFICATION**

ORIGINAL				CROSS REFERENCE(S)								
CLASS		SUBCLASS		CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)							
250		396R		250	49221	49222						
INTERNATIONAL CLASSIFICATION												
G	01	T	1/00									
A	01	N	5/00									
G	21	K	5/11									

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☐ **TERMINAL  
DISCLAIMER**

☐ The term of this patent subsequent to \_\_\_\_\_ has been disclaimed.

☐ The term of this patent shall not extend beyond the expiration of U.S. Patent No. \_\_\_\_\_

☐ The terminal \_\_\_\_ mo  
this patent have been dis

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<b>DRAWINGS</b>			<b>CLAIMS ALLOWED</b>	
Sheets Drwg.	Figs. Drwg.	Print Fig.	Total Claims	Print Claim for O.G.
			<b>NOTICE OF ALLOWANCE MAILED</b>	
(Assistant Examiner)				
			<b>ISSUE FEE</b>	
			Amount Due	Date Paid
(Primary Examiner)				
			<b>ISSUE BATCH NUMBER</b>	
(Legal Instruments Examiner)				

Form PTO-436A  
(Rev. 6/79)

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